

**Notice of References Cited**

 Application/Control No.  
 09/592,599

 Applicant(s)/Patent Under  
 Reexamination  
 WANG ET AL.

 Examiner  
 Nhon (Gary) D Nguyen

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 2174

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5887193 A	03-1999	Takahashi, Fumiaki et al.	710/8
	B	US-6466233 B1	10-2002	Mitani, Hitoshi	345/716
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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